

# < High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

## CM600E1A-66X

HIGH POWER SWITCHING USE  
INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

### CM600E1A-66X



- $I_C$  ..... 600A
- $V_{CES}$  ..... 3300V
- 2-elements in a Pack (for brake chopper\*)
- Insulated Type (Al base type)
- CSTBT™(III) / RFC Diode

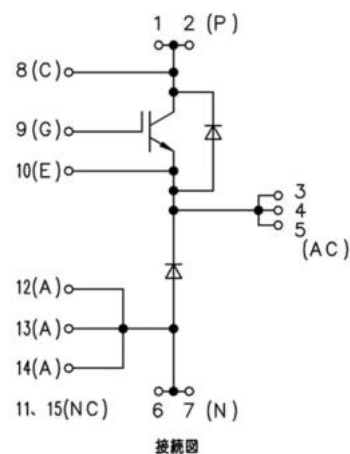
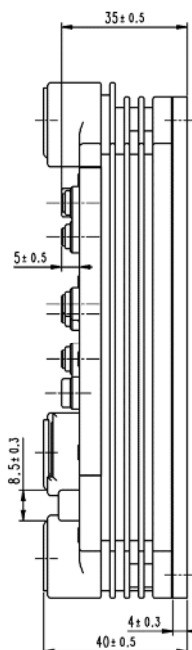
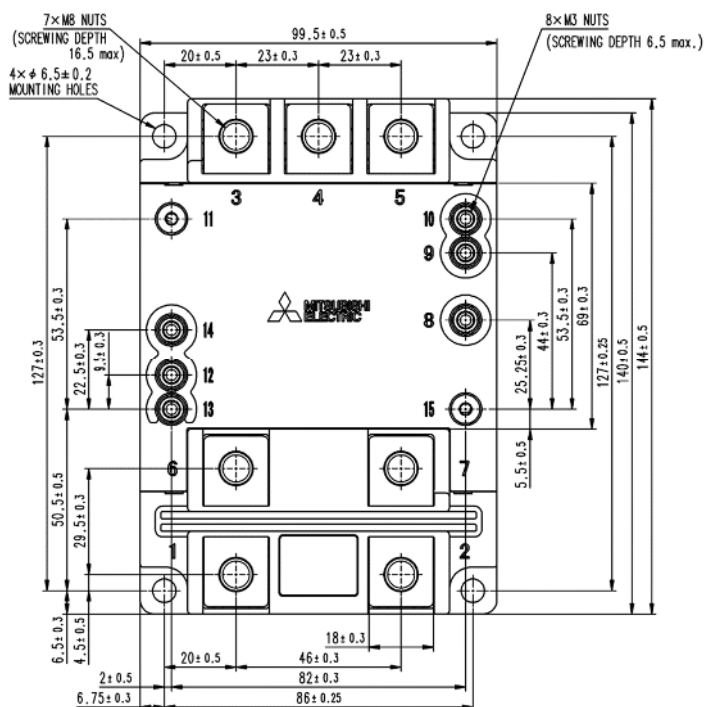
\*Not allowed for 3-level use. Limited to use as a brake chopper.

### APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

### OUTLINE DRAWING & CIRCUIT DIAGRAM

Dimensions in mm



No.12, 13, 14 MUST be open electrically.

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**MAXIMUM RATINGS**

Symbol	Item	Conditions	Ratings	Unit
$V_{CES}$	Collector-emitter voltage	$V_{GE} = 0V, T_j = -40 \dots +150^{\circ}C$	3300	V
		$V_{GE} = 0V, T_j = -50^{\circ}C$	3200	
$V_{GES}$	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	$\pm 20$	V
$I_C$	Collector current	DC, $T_c = 109^{\circ}C$	600	A
$I_{CRM}$		Pulse (Note 1)	1200	A
$I_E$	Emitter current (Note 2)	DC, $T_c = 90^{\circ}C$	600	A
$I_{ERM}$		Pulse (Note 1)	1200	A
$I_F$	Forward current (Note 3)	DC, $T_c = 90^{\circ}C$	600	A
$I_{FRM}$		Pulse (Note 1)	1200	A
$P_{tot}$	Maximum power dissipation (Note 4)	$T_c = 25^{\circ}C$ , IGBT part	5400	W
$V_{iso}$	Isolation voltage	RMS, sinusoidal, $f = 60Hz$ , $t = 1 \text{ min.}$ , $T_c = 25^{\circ}C$	6000	V
$Q_{PD}$	Partial discharge	Charged part to the baseplate $V1 = 3500 \text{ Vrms}$ , $V2 = 2600 \text{ Vrms}$ AC 60 Hz, $T_c = 25^{\circ}C$ (acc. to IEC 61287)	10	pC
$T_j$	Junction temperature		$-50 \sim +150$	$^{\circ}C$
$T_{jop}$	Operating junction temperature		$-50 \sim +150$	$^{\circ}C$
$T_{stg}$	Storage temperature		$-55 \sim +125$	$^{\circ}C$
$t_{psc}$	Short circuit pulse width	$V_{CC} = 2400V$ , $V_{CE} \leq V_{CES}$ , $V_{GE} = 15V$ , $T_j = 150^{\circ}C$ $R_{g(on)} = 2.2\Omega$ , $R_{g(off)} = 51\Omega$ , $C_{GE} = 33nF$	10	$\mu s$

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**ELECTRICAL CHARACTERISTICS**

Symbol	Item	Conditions		Limits			Unit			
				Min	Typ	Max				
I <sub>CES</sub>	Collector cutoff current	V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0V	T <sub>j</sub> = 25°C	—	—	2.0	mA			
			T <sub>j</sub> = 125°C	—	2.0	—				
			T <sub>j</sub> = 150°C	—	—	55.5				
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 60 mA, T <sub>j</sub> = 25°C		6.5	7.0	7.5	V			
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0V, T <sub>j</sub> = 25°C		−0.5	—	0.5	μA			
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 10 V, V <sub>GE</sub> = 0 V, f = 100 kHz T <sub>j</sub> = 25°C		—	53.4	—	nF			
C <sub>oes</sub>	Output capacitance			—	3.8	—	nF			
C <sub>res</sub>	Reverse transfer capacitance			—	0.5	—	nF			
Q <sub>G</sub>	Total gate charge	V <sub>CC</sub> = 1800V, I <sub>C</sub> = 600A, V <sub>GE</sub> = ±15V		—	3.6	—	μC			
V <sub>CEsat</sub>	Collector-emitter saturation voltage	I <sub>C</sub> = 600 A <sup>(Note 5)</sup> V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C	—	2.30	—	V			
			T <sub>j</sub> = 125°C	—	2.80	—				
			T <sub>j</sub> = 150°C	—	2.90	3.30				
t <sub>d(on)</sub>	Turn-on delay time	V <sub>CC</sub> = 1800 V I <sub>C</sub> = 600 A	T <sub>j</sub> = 150°C	—	—	1.25				
t <sub>r</sub>	Rise time		T <sub>j</sub> = 150°C	—	—	0.50				
E <sub>on(10%)</sub>	Turn-on switching energy <sup>(Note 5)</sup>		V <sub>GE</sub> = ±15 V R <sub>G(on)</sub> = 2.2 Ω L <sub>s</sub> = 65nH	T <sub>j</sub> = 25°C	—	0.76	—	J		
		Inductive load C <sub>GE</sub> = 33 nF	T <sub>j</sub> = 125°C	—	0.92	—				
			T <sub>j</sub> = 150°C	—	0.93	—				
E <sub>on</sub>	Turn-on switching energy			T <sub>j</sub> = 25°C	—	0.82	—	J		
		T <sub>j</sub> = 125°C		—	0.99	—				
		T <sub>j</sub> = 150°C		—	1.00	—				
t <sub>d(off)</sub>	Turn-off delay time	V <sub>CC</sub> = 1800 V I <sub>C</sub> = 600 A V <sub>GE</sub> = ±15 V R <sub>G(off)</sub> = 51 Ω L <sub>s</sub> = 65nH Inductive load C <sub>GE</sub> = 33 nF	T <sub>j</sub> = 25°C	—	3.40	—	μs			
			T <sub>j</sub> = 125°C	—	3.60	—				
			T <sub>j</sub> = 150°C	—	3.65	5.00				
t <sub>f</sub>	Fall time			T <sub>j</sub> = 25°C	—	0.23	—	μs		
				T <sub>j</sub> = 125°C	—	0.33	—			
				T <sub>j</sub> = 150°C	—	0.35	1.00			
E <sub>off(10%)</sub>	Turn-off switching energy per pulse <sup>(Note 5)</sup>				T <sub>j</sub> = 25°C	—	0.67	—	J	
					T <sub>j</sub> = 125°C	—	0.91	—		
					T <sub>j</sub> = 150°C	—	0.92	—		
E <sub>off</sub>	Turn-off switching energy per pulse					T <sub>j</sub> = 25°C	—	0.76	—	J
						T <sub>j</sub> = 125°C	—	1.03	—	
						T <sub>j</sub> = 150°C	—	1.04	—	
V <sub>EC</sub>	Emitter-collector voltage <sup>(Note 2)</sup>	I <sub>E</sub> = 600 A <sup>(Note 5)</sup> V <sub>GE</sub> = 0 V				T <sub>j</sub> = 25°C	—	2.10	—	V
						T <sub>j</sub> = 125°C	—	2.30	—	
						T <sub>j</sub> = 150°C	—	2.40	2.90	

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**ELECTRICAL CHARACTERISTICS (Clamp-Di part)**

Symbol	Item	Conditions		Limits			Unit
				Min	Typ	Max	
$I_{RRM}$	Repetitive reverse current (Note 3)	$V_{AK} = V_{RRM}$	$T_J = 25^{\circ}\text{C}$	—	—	1.0	mA
			$T_J = 125^{\circ}\text{C}$	—	1.0	—	
			$T_J = 150^{\circ}\text{C}$	—	—	18.0	
$V_{FM}$	Forward voltage (Note 3)	$I_F = 600\text{ A}$ (Note 5)	$T_J = 25^{\circ}\text{C}$	—	2.10	—	V
			$T_J = 125^{\circ}\text{C}$	—	2.30	—	
			$T_J = 150^{\circ}\text{C}$	—	2.40	2.90	
$t_{rr}$	Reverse recovery time (Note 3)	$V_{CC} = 1800\text{ V}$ $I_C = 600\text{ A}$ $V_{GE} = \pm 15\text{ V}$ $R_{G(on)} = 2.2\ \Omega$ $L_s = 65\text{ nH}$ Inductive load $C_{GE} = 33\text{ nF}$	$T_J = 25^{\circ}\text{C}$	—	0.55	—	$\mu\text{s}$
			$T_J = 125^{\circ}\text{C}$	—	0.65	—	
			$T_J = 150^{\circ}\text{C}$	—	0.70	—	
$I_{rr}$	Reverse recovery current (Note 3)		$T_J = 25^{\circ}\text{C}$	—	1170	—	A
			$T_J = 125^{\circ}\text{C}$	—	1120	—	
			$T_J = 150^{\circ}\text{C}$	—	1100	—	
$Q_{rr(10\%)}$	Reverse recovery charge (Note 3), (Note 7)		$T_J = 25^{\circ}\text{C}$	—	620	—	$\mu\text{C}$
			$T_J = 125^{\circ}\text{C}$	—	740	—	
			$T_J = 150^{\circ}\text{C}$	—	770	—	
$Q_{rr}$	Reverse recovery charge (Note 3)		$T_J = 25^{\circ}\text{C}$	—	650	—	$\mu\text{C}$
			$T_J = 125^{\circ}\text{C}$	—	805	—	
			$T_J = 150^{\circ}\text{C}$	—	845	—	
$E_{rec(10\%)}$	Reverse recovery energy per pulse (Note 3) , (Note 6)		$T_J = 25^{\circ}\text{C}$	—	0.66	—	J
			$T_J = 125^{\circ}\text{C}$	—	0.88	—	
			$T_J = 150^{\circ}\text{C}$	—	0.91	—	
$E_{rec}$	Reverse recovery energy per pulse (Note 3)		$T_J = 25^{\circ}\text{C}$	—	0.75	—	J
			$T_J = 125^{\circ}\text{C}$	—	1.01	—	
			$T_J = 150^{\circ}\text{C}$	—	1.03	—	

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**THERMAL CHARACTERISTICS**

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
$R_{th(l-c)Q}$	Thermal resistance	Junction to Case, IGBT part, 1/2 module	—	—	20.5	K/kW
$R_{th(l-c)D}$	Thermal resistance	Junction to Case, FWDi part, per 1/2 module	—	—	34.0	K/kW
$R_{th(j-c)D}$	Thermal resistance	Junction to Case, Clamp-Di part	—	—	34.0	K/kW
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, Switching part, 1/2 module $\lambda_{grease} = 1W/m \cdot k$ , $D_{(c-s)} = 70\mu m$	—	16.0	—	K/kW

**MECHANICAL CHARACTERISTICS**

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
$M_t$	Mounting torque	Main terminals screw M8	7.0	—	14.0	N·m
$M_s$		Mounting screw M6	3.0	—	6.0	N·m
$M_t$		Auxiliary terminals screw M3	0.4	—	0.8	N·m
$m$	Mass		—	0.75	—	kg
CTI	Comparative tracking index		600	—	—	—
$d_a$	Clearance	Between terminals and baseplate	19.5	—	—	mm
$d_s$	Creepage distance	Between terminals and baseplate	32.0	—	—	mm
$L_{P-P-N}$	Parasitic stray inductance	Between terminal 1, 2 and terminal 6, 7	—	10.0	—	nH
$R_{CC'+EE'}$	Internal lead resistance	$T_C = 25^\circ C$ , Between terminal 1, 2 and terminal 3, 4, 5	—	0.28	—	mΩ
$R_{AA'+KK'}$		$T_C = 25^\circ C$ , Between terminal 3, 4, 5 and terminal 6, 7	—	0.18	—	mΩ
$r_g$	Internal gate resistance	$T_C = 25^\circ C$	—	0.83	—	Ω

Note1. Pulse width and repetition rate should be such that junction temperature ( $T_j$ ) does not exceed  $T_{jopmax}$  rating.

- The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD).
- The symbols represent characteristics of the clamp diode (Clamp-Di).
- Junction temperature ( $T_j$ ) should not exceed  $T_{jmax}$  rating ( $150^\circ C$ ).
- Pulse width and repetition rate should be such as to cause negligible temperature rise.
- The integration range of switching energies is from  $10\%V_{CE}$  to  $10\%I_C(10\%I_E)$ .
- The integration range of reverse recovery charge is from  $I_E = 0A$  to  $10\%I_E$ .

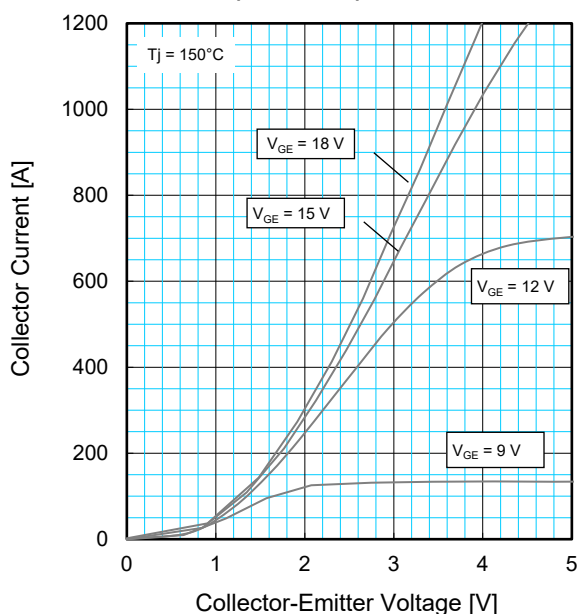
# CM600E1A-66X

HIGH POWER SWITCHING USE  
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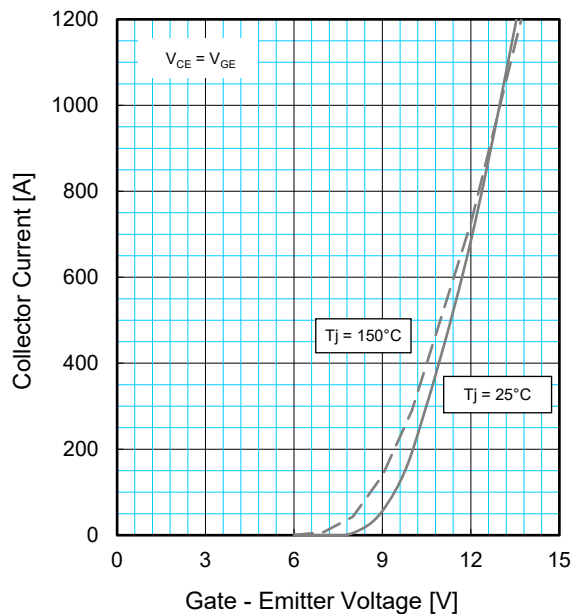
5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

## PERFORMANCE CURVES

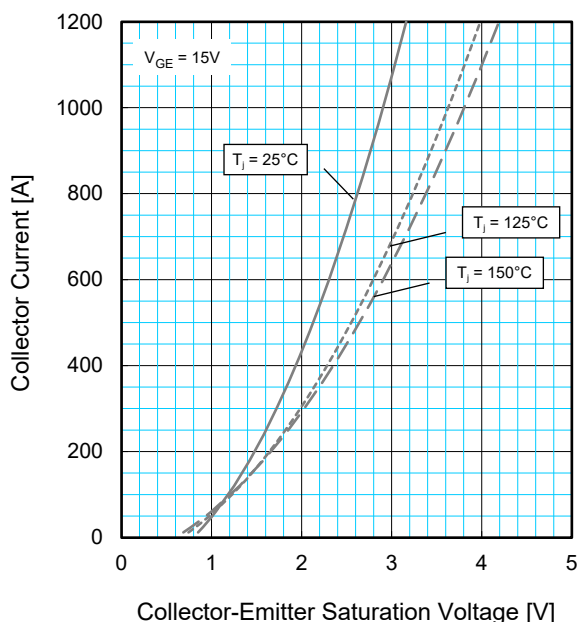
**OUTPUT CHARACTERISTICS  
(TYPICAL)**



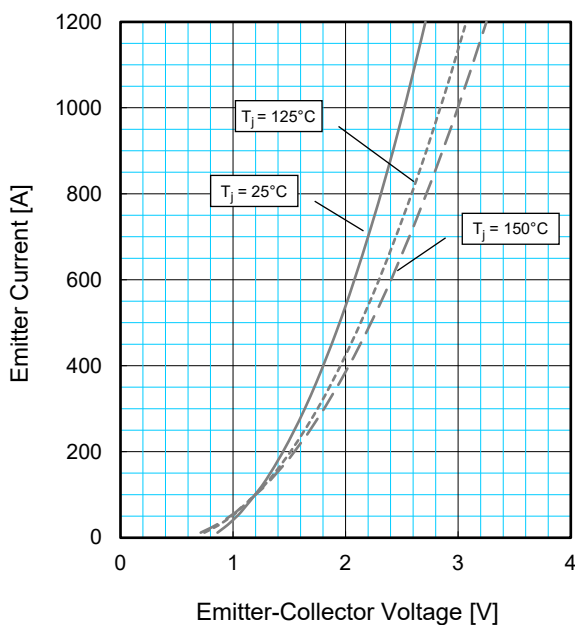
**TRANSFER CHARACTERISTICS  
(TYPICAL)**



**COLLECTOR-EMITTER SATURATION VOLTAGE  
CHARACTERISTICS (TYPICAL)**



**DIODE FORWARD  
CHARACTERISTICS (TYPICAL)**



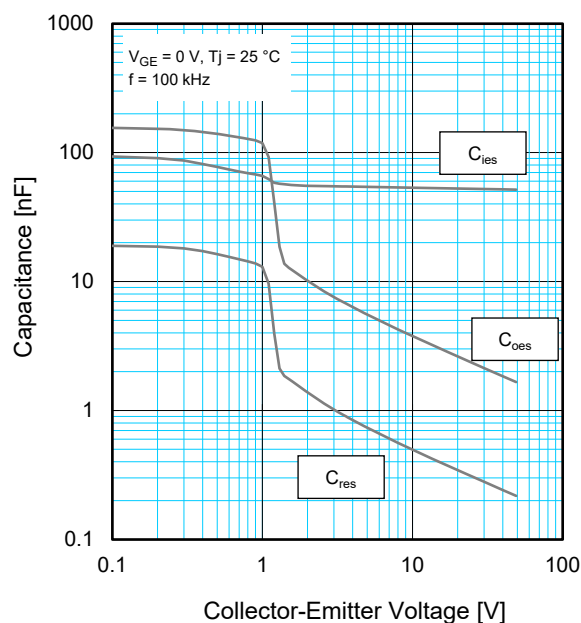
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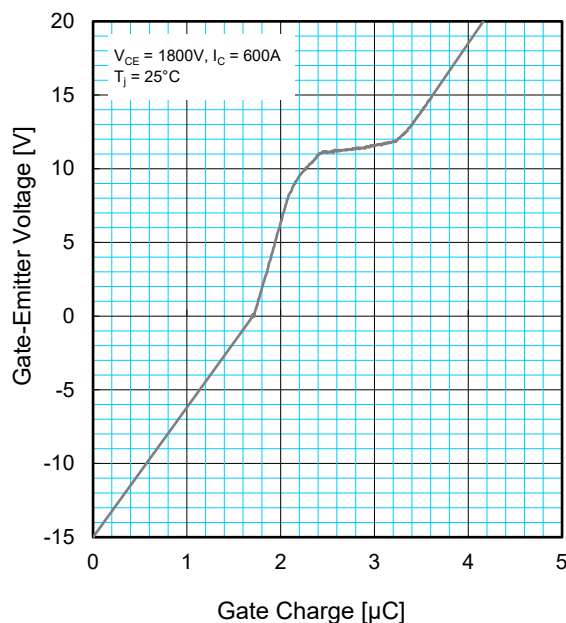
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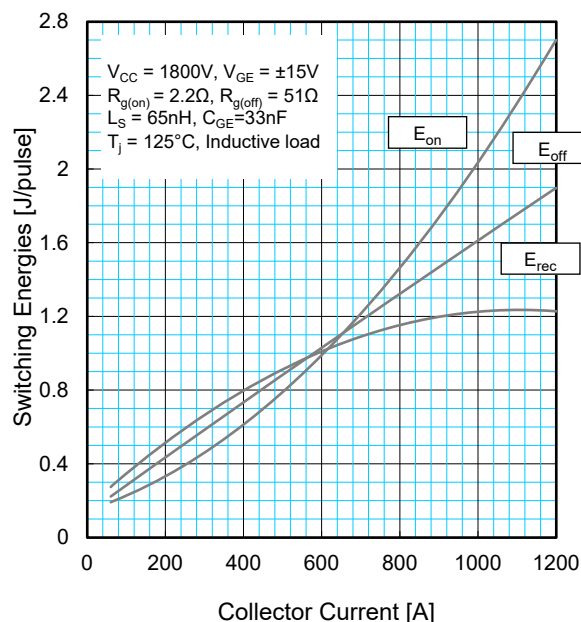
**CAPACITANCE CHARACTERISTICS  
(TYPICAL)**



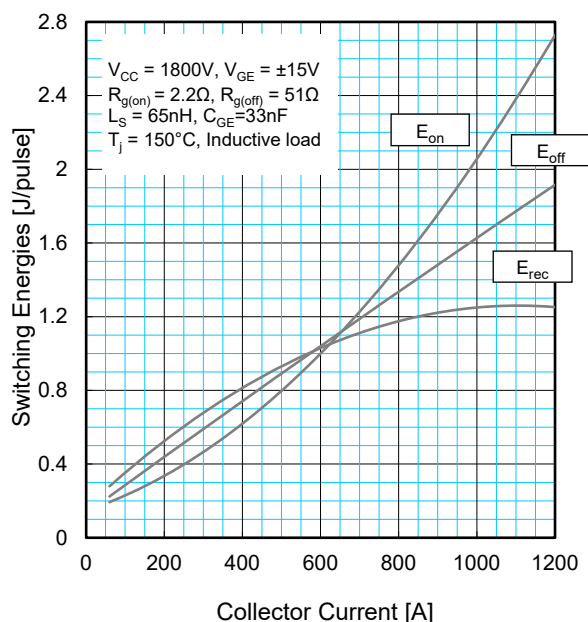
**GATE CHARGE CHARACTERISTICS  
(TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY  
CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY  
CHARACTERISTICS (TYPICAL)**



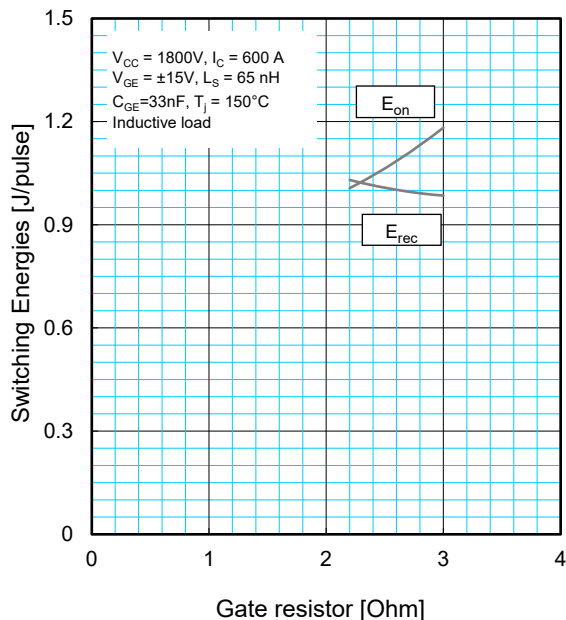
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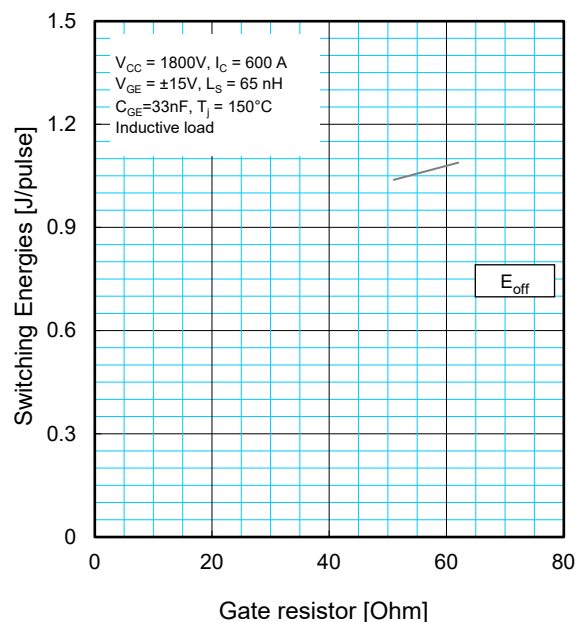
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## PERFORMANCE CURVES

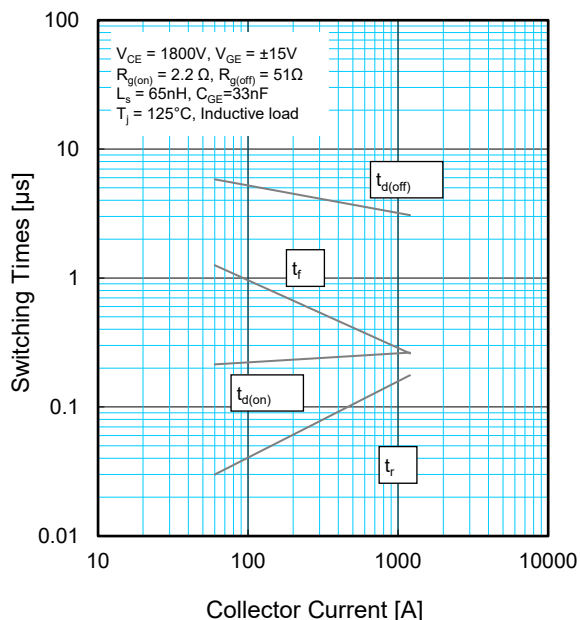
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



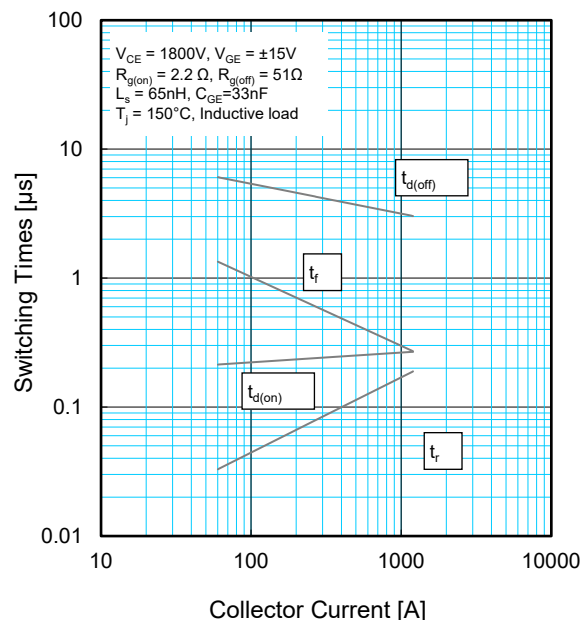
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)





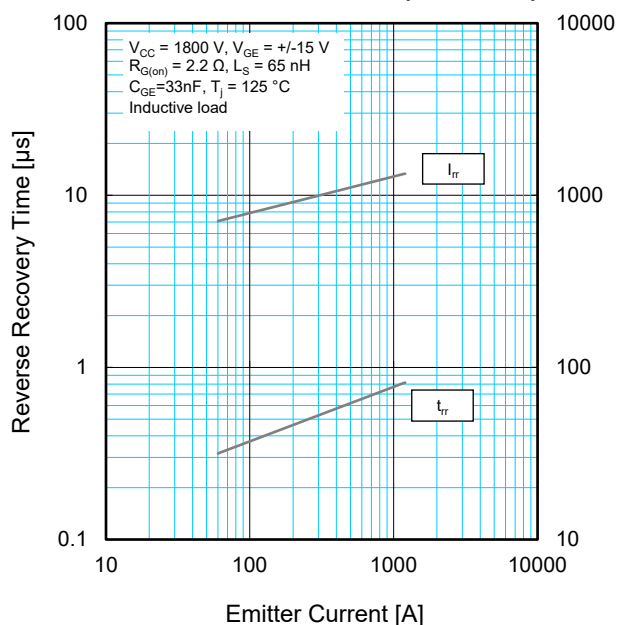
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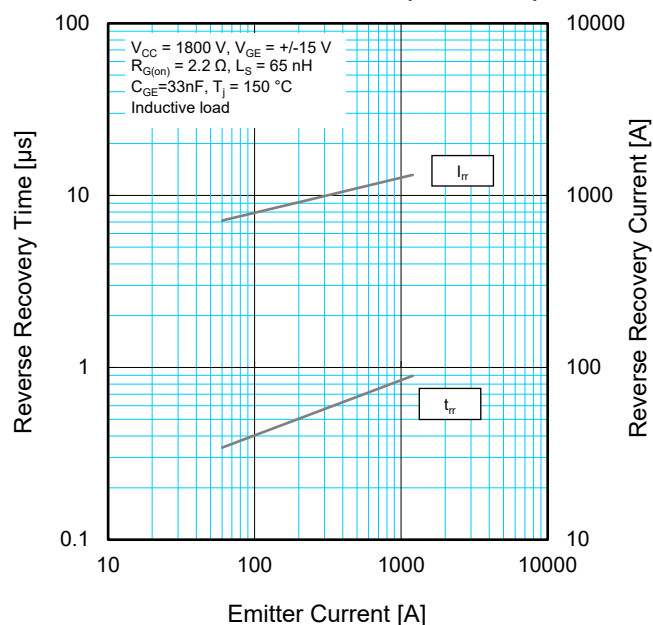
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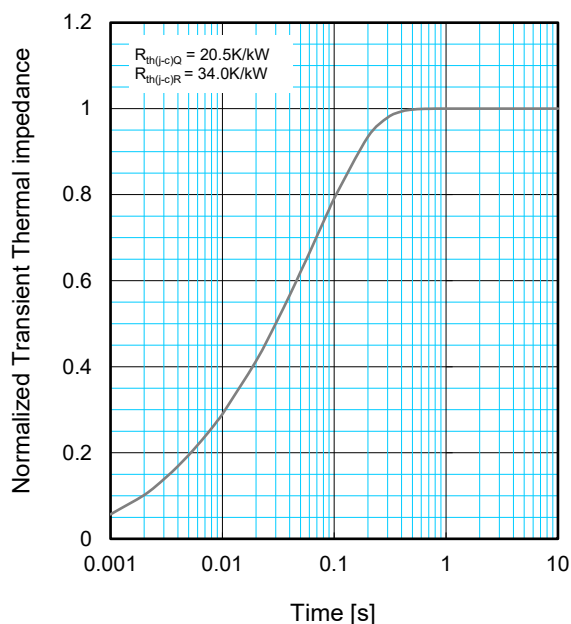
DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

	1	2	3	4
$R_i / R_{th}$ :	0.0292	0.0832	0.2277	0.6599
$\tau_i$ [sec.] :	0.0025	0.0027	0.0155	0.0865

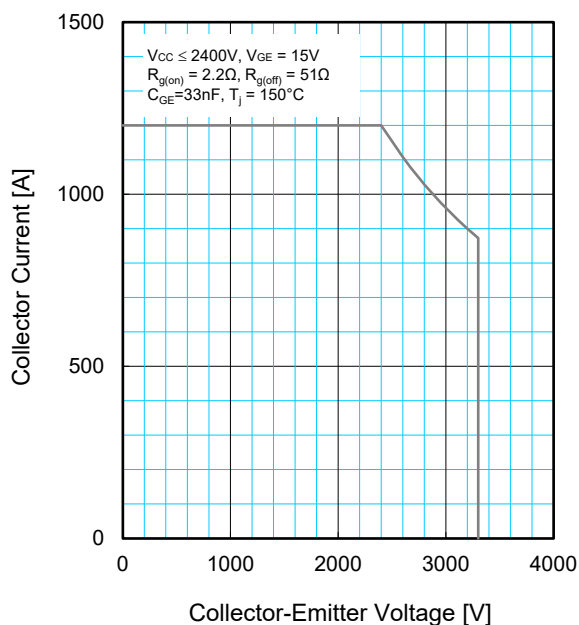
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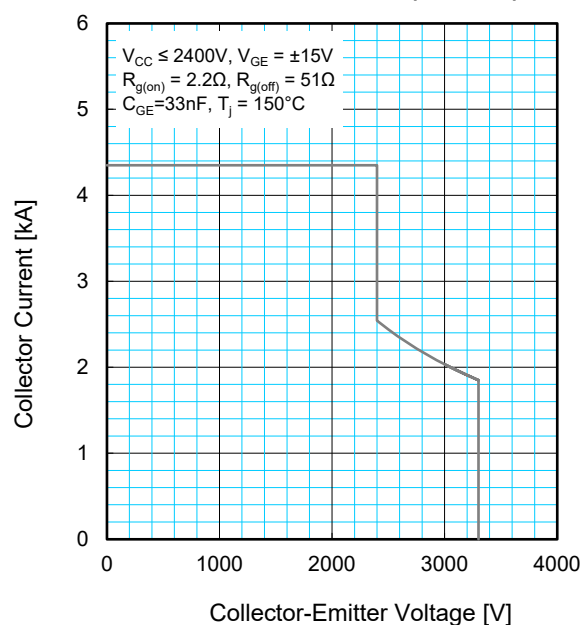
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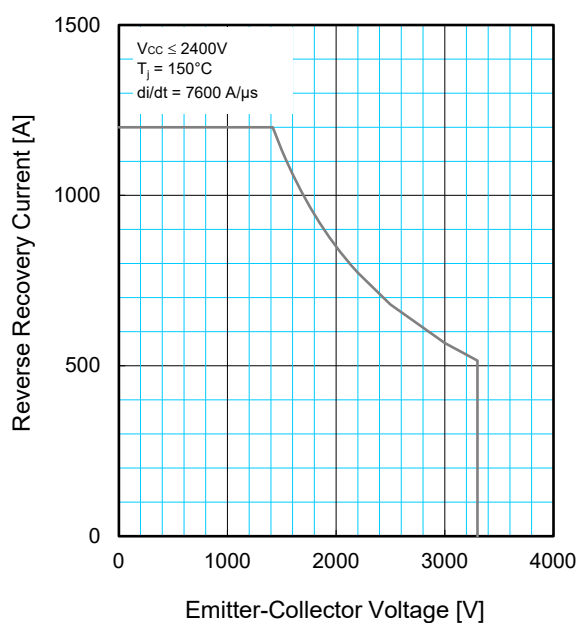
**REVERSE BIAS SAFE OPERATING AREA (RBSOA)**



**SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)**



**DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)**



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**Important Notice**

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